

TEST REPORT

Applicant: NOTHING TECHNOLOGY LIMITED
Address: Bedford House 21A John Street, London, United Kingdom WC1N 2BF
Equipment Type: headphone
Model Name: B186
Brand Name: NOTHING
47 CFR Part 15 Subpart B
Test Standard: ICES-003 (Issue 7, October 15, 2020)
ANSI C63.4-2014
Sample Arrival Date: Oct. 20, 2025
Test Date: Oct. 22, 2025
Date of Issue: Feb. 05, 2026

ISSUED BY:

Shenzhen BALUN Technology Co., Ltd.

**Tested by:** Xiao Tangqi**Checked by:** Xiong Chong**Approved by:** Tolan Tu
(Testing Director)

Revision History

Version	Issue Date	Revisions Content
<u>Rev. 01</u>	<u>Feb. 05, 2026</u>	<u>Initial Issue</u>

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1 GENERAL INFORMATION

1.1 Test Laboratory

Name	Shenzhen BALUN Technology Co., Ltd.
Address	Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Phone Number	+86 755 6685 0100

1.2 Test Location

Name	Shenzhen BALUN Technology Co., Ltd.
Location	☒ Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
	☐ 1/F, Building B, Ganghongji High-tech Intelligent Industrial Park, No. 1008, Songbai Road, Yangguang Community, Xili Sub-district, Nanshan District, Shenzhen, Guangdong Province, P. R. China
	☐ Building 2, Intelligent Connected Vehicle Industrial Park, No. 55, Xiangshan Road, Luotian Community, Yanluo Sub-district, Bao'an District, Shenzhen
Accreditation Certificate	The laboratory is a testing organization accredited by FCC as a accredited testing laboratory. The designation number is CN1196. The certification body is American Association for Laboratory Accreditation (A2LA).

2 PRODUCT INFORMATION

2.1 Applicant Information

Applicant	NOTHING TECHNOLOGY LIMITED
Address	Bedford House 21A John Street, London, United Kingdom WC1N 2BF

2.2 Manufacturer Information

Manufacturer	NOTHING TECHNOLOGY LIMITED
Address	Bedford House 21A John Street, London, United Kingdom WC1N 2BF

2.3 General Description for Equipment under Test (EUT)

EUT Name	headphone
Model Name Under Test	B186
Series Model Name	N/A
Description of Model name differentiation	N/A
Hardware Version	V0.3
Software Version	N/A
Dimensions (Approx.)	N/A
Weight (Approx.)	N/A
Serial Number	N/A

2.4 Ancillary Equipment

Ancillary Equipment 1	Li-Polymer Battery	
	Brand Name	VDL
	Model No.	721255PN4
	Serial No.	N/A
	Capacitance	530mAh
	Rated Voltage	3.85 V
	Limited Voltage	4.4 V
	Manufacturer	Chongqing VDL Electronics Co., Ltd.

2.5 Technical Information

Network and Wireless connectivity	Bluetooth
Classification of equipment	Class B
The highest internal frequency of EUT	2480 MHz

3 SUMMARY OF TEST RESULTS

3.1 Test Standards

No.	Identity	Document Title
1	47 CFR Part 15 Subpart B	Unintentional Radiators
2	ICES-003 (Issue 7, October 15, 2020)	Information Technology Equipment (Including Digital Apparatus)
3	ANSI C63.4-2014	American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz

3.2 Verdict

No.	Description	FCC Rule	ISED Rule	Test Verdict	Remark
1	Radiated Emission	15.109	ICES-003, 3.2.2	Pass	--
2	Conducted Emission, AC Ports	15.107	ICES-003, 3.2.1	Pass	--

3.3 Test Uncertainty

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of $k=2$.

Measurement	Value
Conducted emissions (9 kHz-30 MHz)	3.2 dB
Radiated emissions (30 MHz-1 GHz)-966#4	4.4 dB
Radiated emissions (1 GHz-18 GHz)-966#4	5.0 dB

4 GENERAL TEST CONFIGURATIONS

4.1 Test Enclosure List

Description	Manufacturer	Model	Serial No.	Length	Description	Use
Mobile Phone	XIAOMI	MI 5X	MP-XM-002	N/A	N/A	☒
Adapter	OPPO	0P52YAUH	N/A	N/A	N/A	☒
USB Cable	OPPO	N/A	N/A	1m	N/A	☒
Adapter	OPPO	VC54GBCH	N/A	N/A	N/A	☒
AUX Cable	UGREEN	N/A	N/A	0.5m	N/A	☒

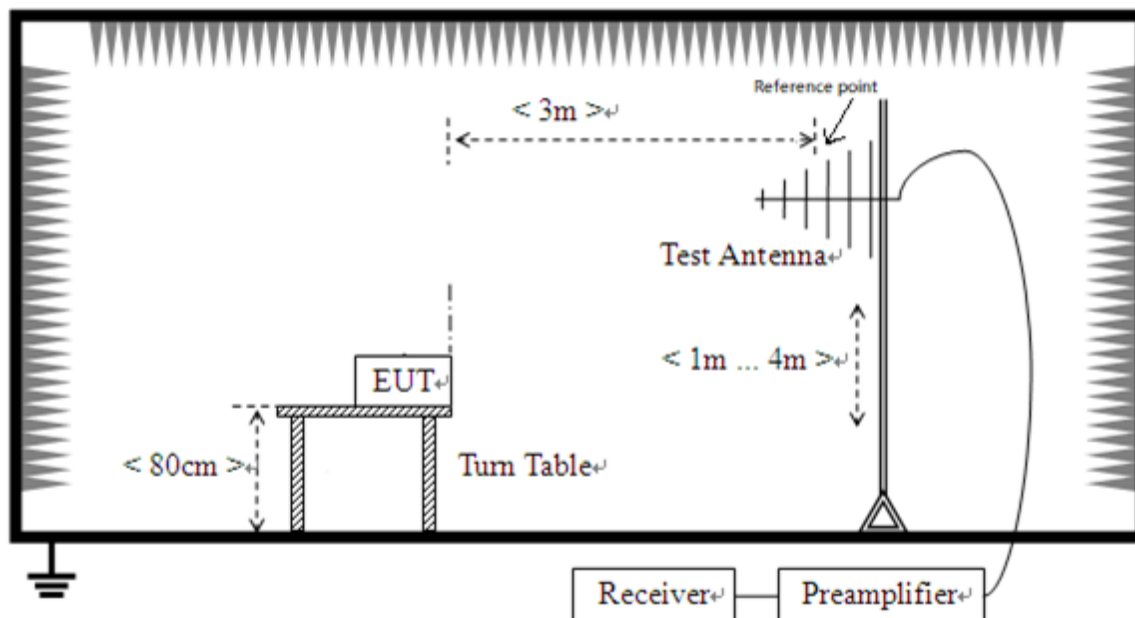
4.2 Test Configurations

All test modes of EUT are listed in the table below.

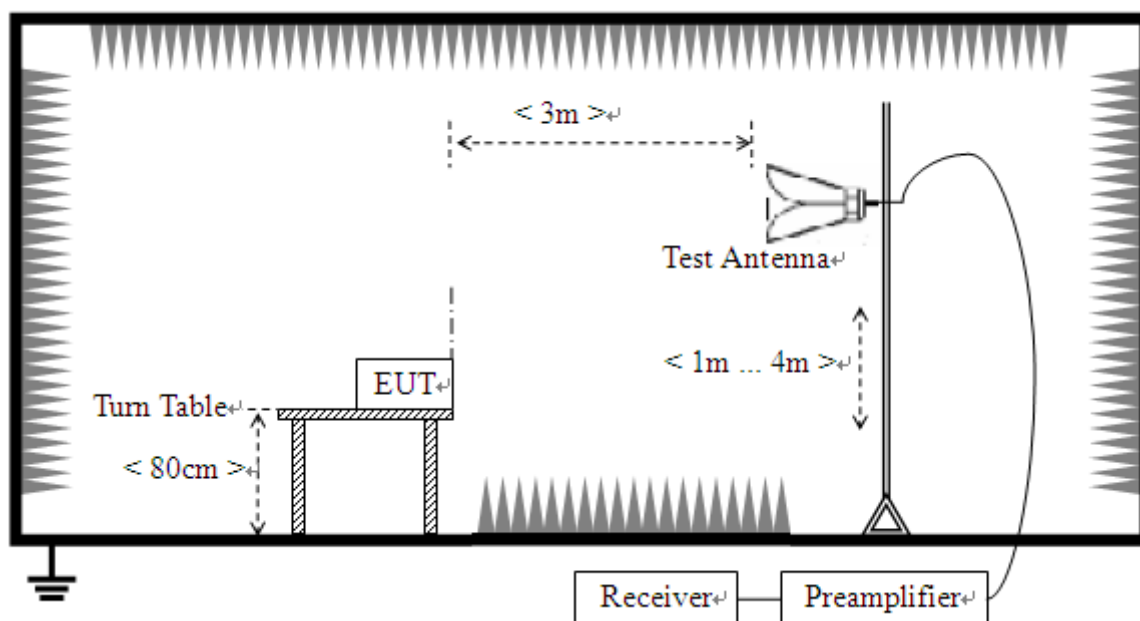
Test Mode Configuration	Description
Mode 1	<u>The AUX Test Mode</u> EUT + Adapter + USB Cable + Mobile phone + AUX Cable

4.3 Test Setups

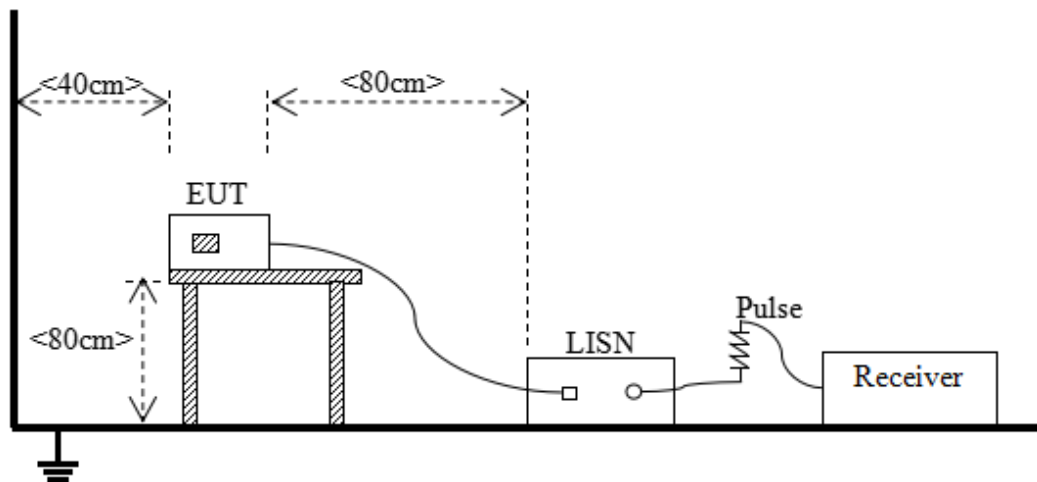
Test Setup 1



Radiated Emission (30 MHz-1 GHz)



Radiated Emission (above 1 GHz)

Test Setup 2

Conducted Emissions, AC Ports

5 TEST ITEMS

5.1 Emission Tests

5.1.1 Radiated Emission

5.1.1.1 Limit

FCC:

Frequency range (MHz)	Class B (at 3 m)		Class A (at 3 m)
	Field Strength ($\mu\text{V/m}$)	Field Strength (dB $\mu\text{V/m}$)	Field Strength (dB $\mu\text{V/m}$)
30 - 88	100	40	49.5
88 - 216	150	43.5	54
216 - 960	200	46	56.9
Above 960	500	54	60

NOTE:

- 1) Field Strength (dB $\mu\text{V/m}$) = $20 \times \log [\text{Field Strength } (\mu\text{V/m})]$.
- 2) In the emission tables above, the tighter limit applies at the band edges.
- 3) For 30 MHz to 1000 MHz, the CISPR quasi-peak is employed.

For above 1000 MHz, according to the requirements of FCC 15.35, unless otherwise specified, the limit on peak radio frequency emissions is 20 dB above the maximum permitted average emission limit applicable to the equipment under test.

Frequency range (GHz)	Class B (at 3 m)			Class A (at 3 m)	
	Field Strength ($\mu\text{V/m}$)	Field Strength Average (dB $\mu\text{V/m}$)	Field Strength Peak (dB $\mu\text{V/m}$)	Field Strength Average (dB $\mu\text{V/m}$)	Field Strength Peak (dB $\mu\text{V/m}$)
1 - F_M	500	54	74	60	80

Note 1: The highest measurement frequency, F_M , in GHz, shall be determined as next Table.

Note 2: Average Class A limit at 3m L_{3m} is determined by the following conversion formula:
 $L_{3m} = L_{10m} + 20 \times \log(d_{10m}/d_{3m})$
 Where:
 L_{3m} is Average Class A limit at 3m;
 L_{10m} is Average Class A limit at 10m;
 d_{10m} is Measurement distance in 10m;
 d_{3m} is Measurement distance in 3m.
 For this case: $L_{3m} = 49.5 + 20 \times \log(10/3) = 60$ (dB $\mu\text{V/m}$).

Highest internal frequency (F_X)	Highest measurement frequency (F_M)
$F_X \leq 108$ MHz	1 GHz
$108 \text{ MHz} \leq F_X \leq 500$ MHz	2 GHz
$500 \text{ MHz} \leq F_X \leq 1$ GHz	5 GHz
$F_X \geq 1$ GHz	$5 \times F_X$

Highest internal frequency (F_X)	Highest measurement frequency (F_M)
	or 40 GHz, whichever is lower.
Note: F_X is Highest frequency generated or used in the device or on which the device operates or tunes.	

IC:

Frequency range (MHz)	Class A (3 m)	Class B (3 m)
	Quasi-peak (dB μ V/m)	Quasi-peak (dB μ V/m)
30 - 88	50.0	40.0
88 - 216	54.0	43.5
216 - 230	56.9	46.0
230 - 960	57.0	47.0
960 - 1000	60.0	54.0
Note: The more stringent limit applies at transition frequencies.		

Frequency range (GHz)	Class A (3 m)		Class B (3 m)	
	Average (dB μ V/m)	Peak (dB μ V/m)	Average (dB μ V/m)	Peak (dB μ V/m)
1 - F_M	60	80	54	74

Note:

1. The highest measurement frequency, F_M , in GHz, shall be determined as next Table.
2. The measurement bandwidth shall be 1 MHz or greater.
3. These limit levels apply for a measurement distance of 3 m. If using a different measurement distance, the measured levels shall be extrapolated to the 3 m limit distance using a factor of 20 dB per decade of distance. The measurement distance shall place the measurement antenna in the far field of the ITE or digital apparatus under test.
4. The test site shall have been validated at the distance used for radiated emission measurements on the ITE or digital apparatus under test.

Highest internal frequency (F_X)	Highest measurement frequency (F_M)
$F_X \leq 108$ MHz	1GHz
108 MHz $\leq F_X \leq 500$ MHz	2GHz
500 MHz $\leq F_X \leq 1$ GHz	5GHz
$F_X \geq 1$ GHz	5 * F_X up to a maximum of 40 GHz

Note: F_X is the highest fundamental frequency generated and/or used in the ITE or digital apparatus under test.

5.1.1.2 Test Setup

Refer to 4.3 section (test setup 1) for radiated emission test, the photo of test setup please refer to ANNEX B.

5.1.1.3 Test Procedure

The test employing the methods of measurement described in the publication referenced in ICES-003 Section 3(b) (ANSI C63.4) and ANSI C63.4;

All Radiated Emission tests were performed in X, Y, Z axis direction. And only the worst axis test condition was recorded in this test report.

An initial pre-scan was performed in the chamber using the EMI Receiver in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by Bi-Log antenna with 2 orthogonal polarities.

The measurement frequency range is from 30 MHz to the 5th harmonic of the maximum frequency of the EUT internal source. The Turn Table is actuated to turn from 0° to 360°, and both horizontal and vertical polarizations of the Test Antenna are used to find the maximum radiated power. Mid channels on all channel bandwidth verified. Only the worst RB size/offset presented.

Use the following spectrum analyzer settings:

Span = wide enough to fully capture the emission being measured

RBW = 1 MHz for $f \geq 1$ GHz, 100 kHz for $f < 1$ GHz

VBW $\geq$ RBW

Sweep = auto

Detector function = peak for $f < 1$ GHz, peak & RMS Average for $f \geq 1$ GHz

Trace = max hold

5.1.1.4 Test Result and Test Equipment List

Please refer to ANNEX A.1.

NOTE:

1. Results (dB μ V/m) = Reading (dB μ V) + Factor (dB/m)

The reading level is calculated by software which is not shown in the sheet

2. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Amplifier Gain (dB)

3. Margin = Limit – Results

5.1.2 Conducted Emission, AC Ports

5.1.2.1 Test Limit

Frequency range (MHz)	Class A	
	Quasi-peak (dB μ V)	Average (dB μ V)
0.15 - 0.50	79	66
0.50 - 30	73	60

Frequency range (MHz)	Class B	
	Quasi-peak (dB μ V)	Average (dB μ V)
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

NOTE:

- 1) The lower limit shall apply at the band edges.
- 2) The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50 MHz.
- 3) The limit using ANSI C63.4.

5.1.2.2 Test Setup

Refer to 4.3 section test (test setup 2) for conducted emission, the photo of test setup please refer to ANNEX B.

5.1.2.3 Test Procedure

The test employing the methods of measurement described in the publication referenced in Section 3(b) (ANSI C63.4);

The EUT is connected to the power mains through a LISN which provides 50 Ω /50 μ H of coupling impedance for the measuring instrument. The test frequency range is from 150 kHz to 30 MHz. The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels that are more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed.

Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. A device rated for 50/60 Hz operation need not be tested at both frequencies provided the radiated and line conducted emissions are the same at both frequencies.

Use the following spectrum analyzer settings:

RBW = 9 kHz

VBW $\geq$ RBW

Sweep = 10ms

Detector function =peak & Average

Trace = max hold

5.1.2.4 Test Result and Test Equipment List

Please refer to ANNEX A.2.

NOTE:

1. Results (dBμV) = Reading (dBμV) + Factor (dB)

The reading level is calculated by software which is not shown in the sheet

2. Factor = Insertion loss + Cable loss

3. Margin = Limit – Results

ANNEX A TEST RESULTS

A.1 Radiated Emission

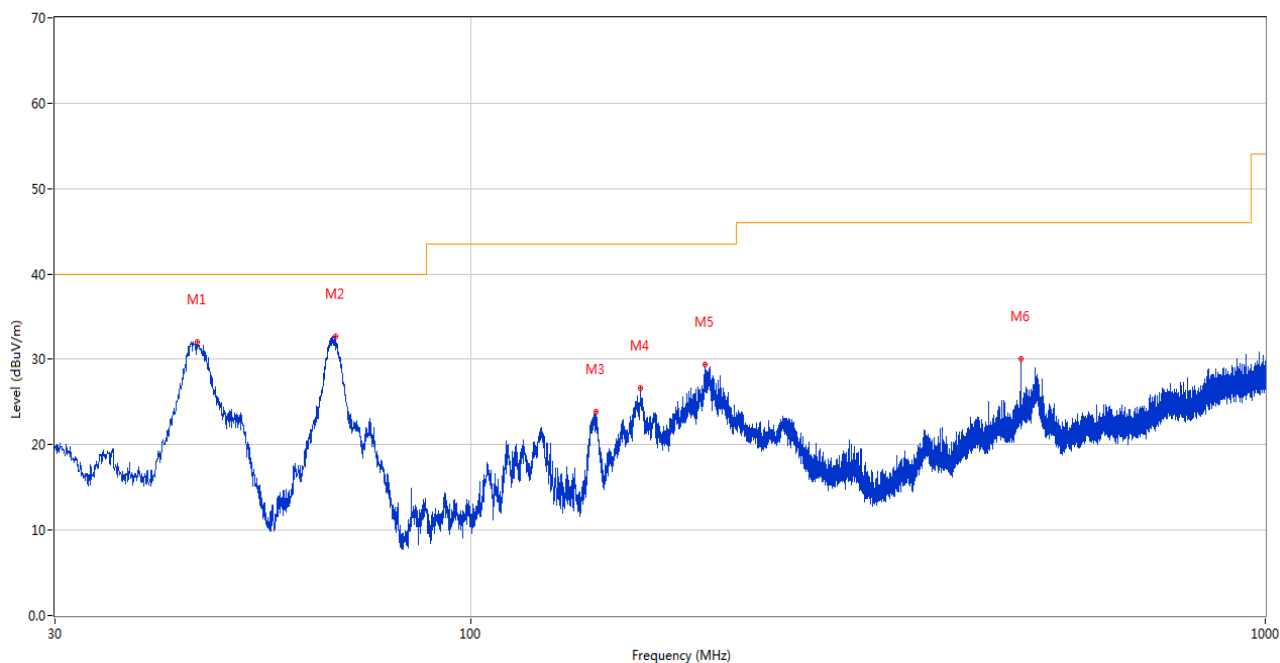
Note 1: For the test data above 1 GHz, according the ANSI C63.4-2014, where limits are specified for both average and peak (or quasi-peak) detector functions, if the peak (or quasi-peak) measured value complies with the average limit, it is unnecessary to perform an average measurement.

Note 2: The Radiated Emission is required to be investigated to the upper frequency of 5th harmonic of the highest internal frequency of EUT or 40 GHz, whichever is lower. The test results above 18GHz are only noise and are not recorded in the report

Sample No.	S05	Temperature	24.2℃
Humidity	40%RH	Pressure	101kPa
Test Engineer	Li Jianping	Test Date	2025.10.22

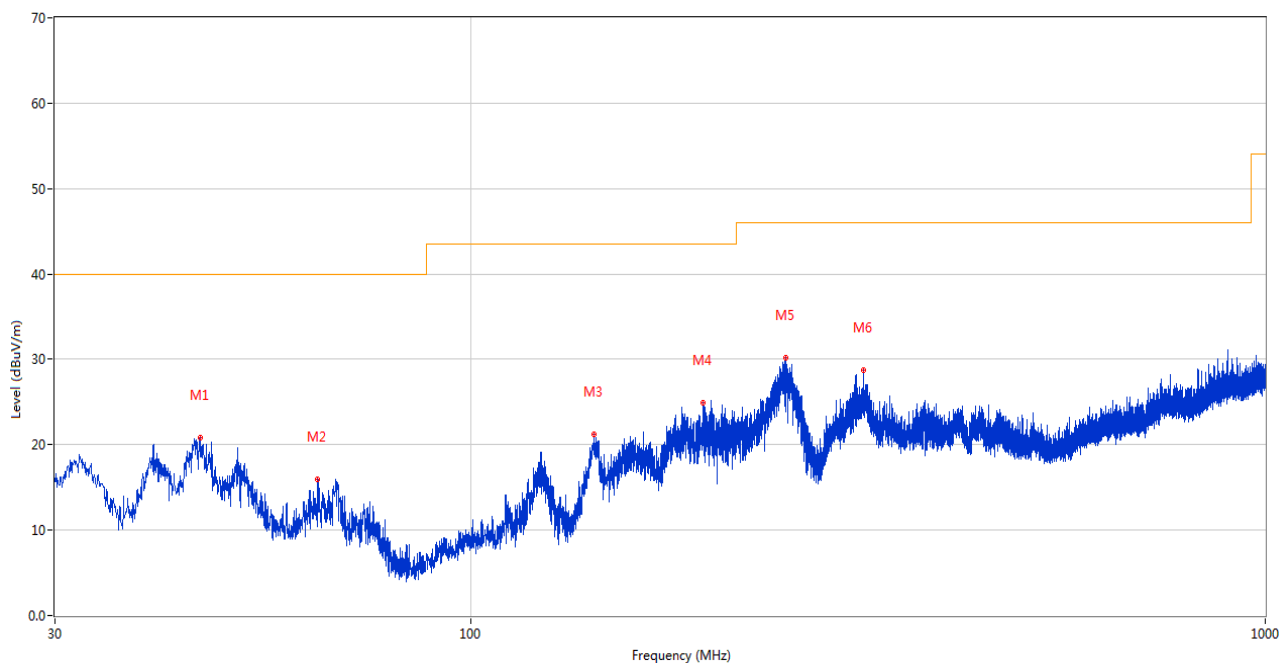
Test Mode 1

1) Test Antenna Vertical, 30 MHz – 1 GHz (FCC)



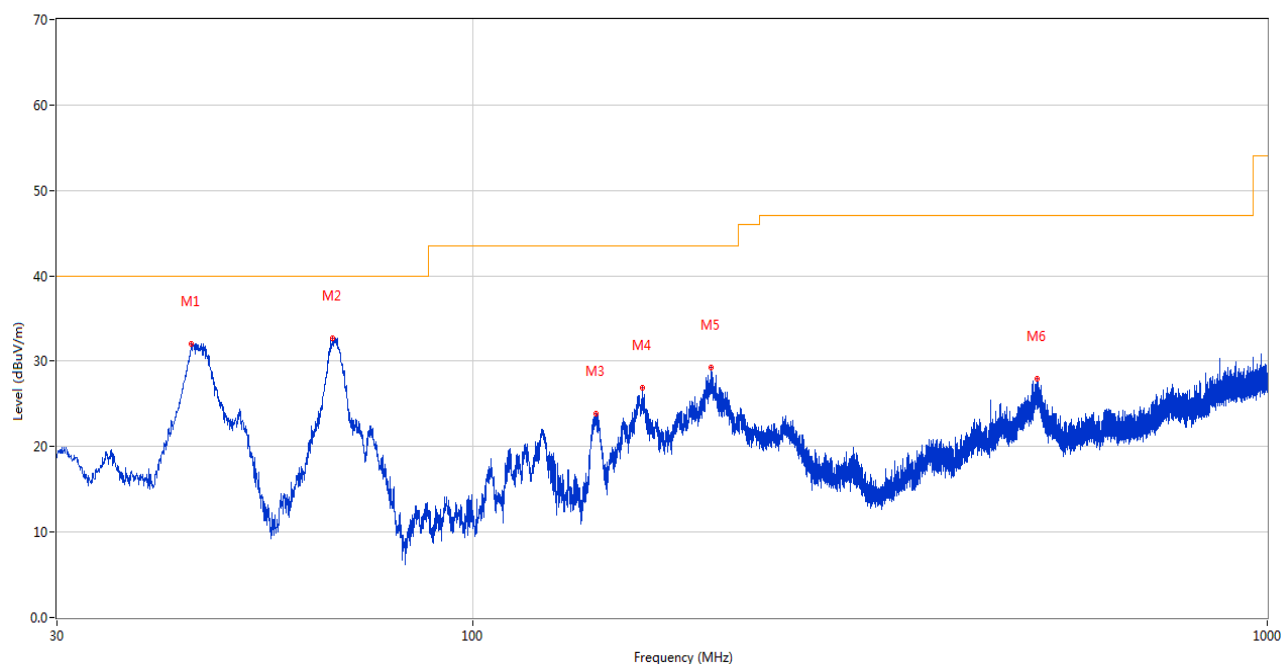
No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	45.326	32.08	-25.24	40.0	7.92	Peak	147.30	100	Vertical	Pass
2	67.636	32.67	-28.30	40.0	7.33	Peak	140.10	100	Vertical	Pass
3	143.684	23.91	-29.60	43.5	19.59	Peak	257.10	100	Vertical	Pass
4	163.423	26.67	-28.66	43.5	16.83	Peak	307.90	100	Vertical	Pass
5	197.568	29.43	-25.56	43.5	14.07	Peak	159.50	100	Vertical	Pass
6	492.205	30.10	-18.43	46.0	15.90	Peak	312.60	100	Vertical	Pass

2) Test Antenna Horizontal, 30 MHz – 1 GHz (FCC)



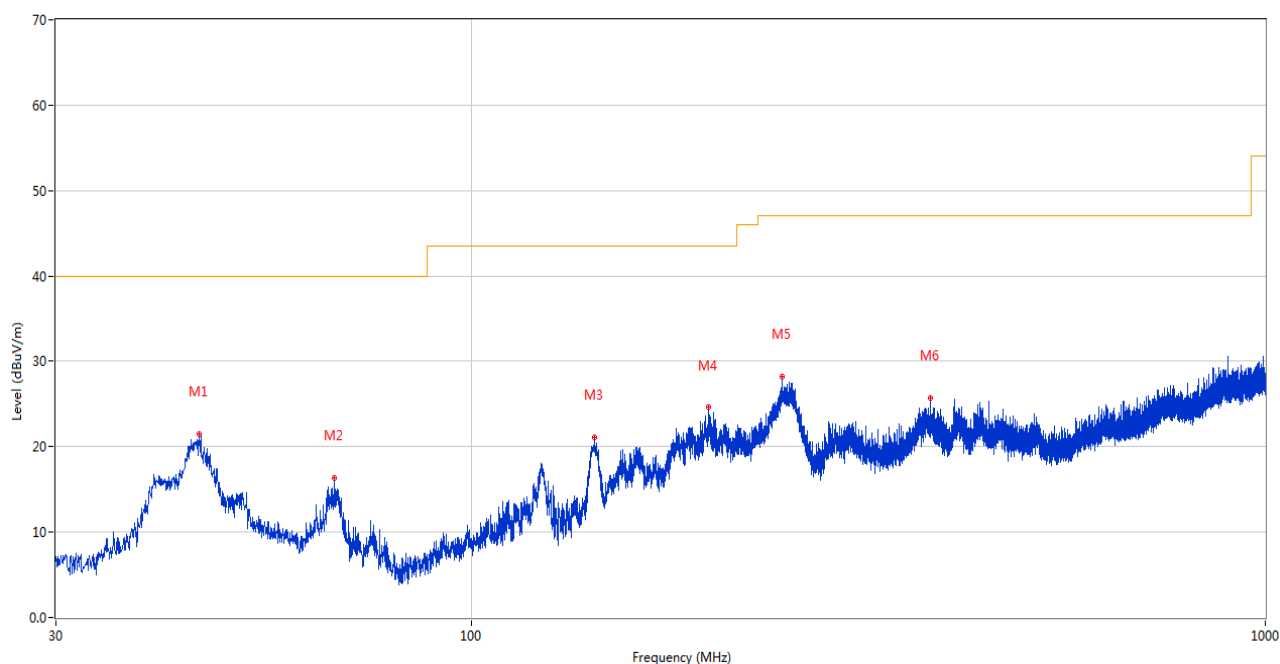
No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	45.666	20.82	-25.19	40.0	19.18	Peak	188.20	100	Horizontal	Pass
2	64.241	16.00	-27.11	40.0	24.00	Peak	61.70	100	Horizontal	Pass
3	143.005	21.21	-29.48	43.5	22.29	Peak	1.00	100	Horizontal	Pass
4	196.306	24.98	-25.65	43.5	18.52	Peak	109.30	100	Horizontal	Pass
5	249.559	30.20	-24.52	46.0	15.80	Peak	130.80	100	Horizontal	Pass
6	312.222	28.72	-23.14	46.0	17.28	Peak	99.70	100	Horizontal	Pass

3) Test Antenna Vertical, 30 MHz – 1 GHz (IC)



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	44.307	32.09	-25.44	40.0	7.91	Peak	107.40	100	Vertical	Pass
2	66.569	32.73	-27.96	40.0	7.27	Peak	148.80	100	Vertical	Pass
3	143.199	23.87	-29.51	43.5	19.63	Peak	272.30	100	Vertical	Pass
4	163.763	26.87	-28.53	43.5	16.63	Peak	304.40	100	Vertical	Pass
5	199.702	29.28	-25.64	43.5	14.22	Peak	156.50	100	Vertical	Pass
6	512.721	27.99	-18.07	47.0	19.01	Peak	193.10	100	Vertical	Pass

4) Test Antenna Horizontal, 30 MHz – 1 GHz (IC)

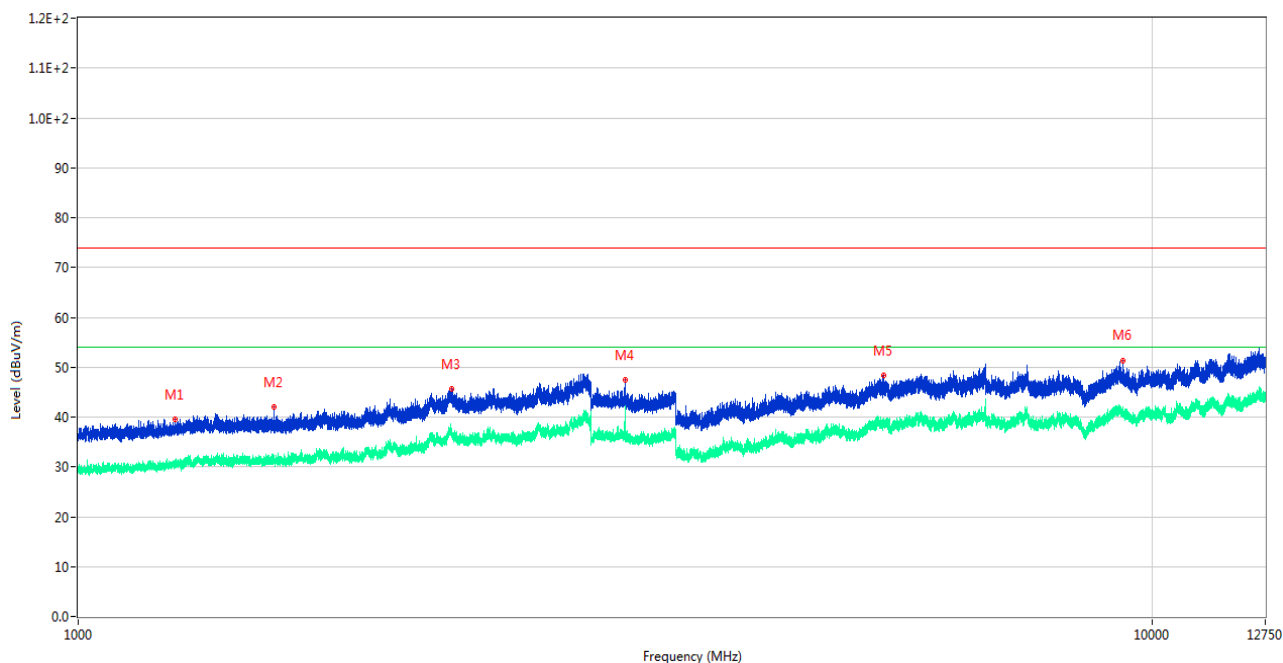


No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	45.423	21.53	-25.23	40.0	18.47	Peak	170.50	100	Horizontal	Pass
2	67.345	16.37	-28.25	40.0	23.63	Peak	219.30	100	Horizontal	Pass
3	142.908	21.08	-29.46	43.5	22.42	Peak	192.70	100	Horizontal	Pass
4	199.265	24.59	-25.63	43.5	18.91	Peak	98.50	100	Horizontal	Pass
5	246.553	28.22	-24.47	47.0	18.78	Peak	144.50	100	Horizontal	Pass
6	378.958	25.71	-21.26	47.0	21.29	Peak	137.30	100	Horizontal	Pass

Equipment Information						
Equipment Name	Supplier	Model	Serial No.	Cal. Date	Cal. Due	Use
Frequency Below 1 GHz						
EMI Receiver	Keysight	N9038A	MY53220118	2025.06.16	2026.06.15	☒
Amplifier (30MHz-1GHz)	COM-MV	ZT30-1000M	B2017119082	2024.11.28	2025.11.27	☒
Test Antenna- Bi-Log	SCHWARZB ECK	VULB 9163	9163-624	2024.07.06	2027.07.05	☒
Anechoic Chamber (#4)	ChangNing	9m*6m*6m	101	2023.03.04	2026.03.03	☒
Description	Supplier	Name	Version	/		Use
Test Software	BALUN	BL410-E	V22.930	/		☒

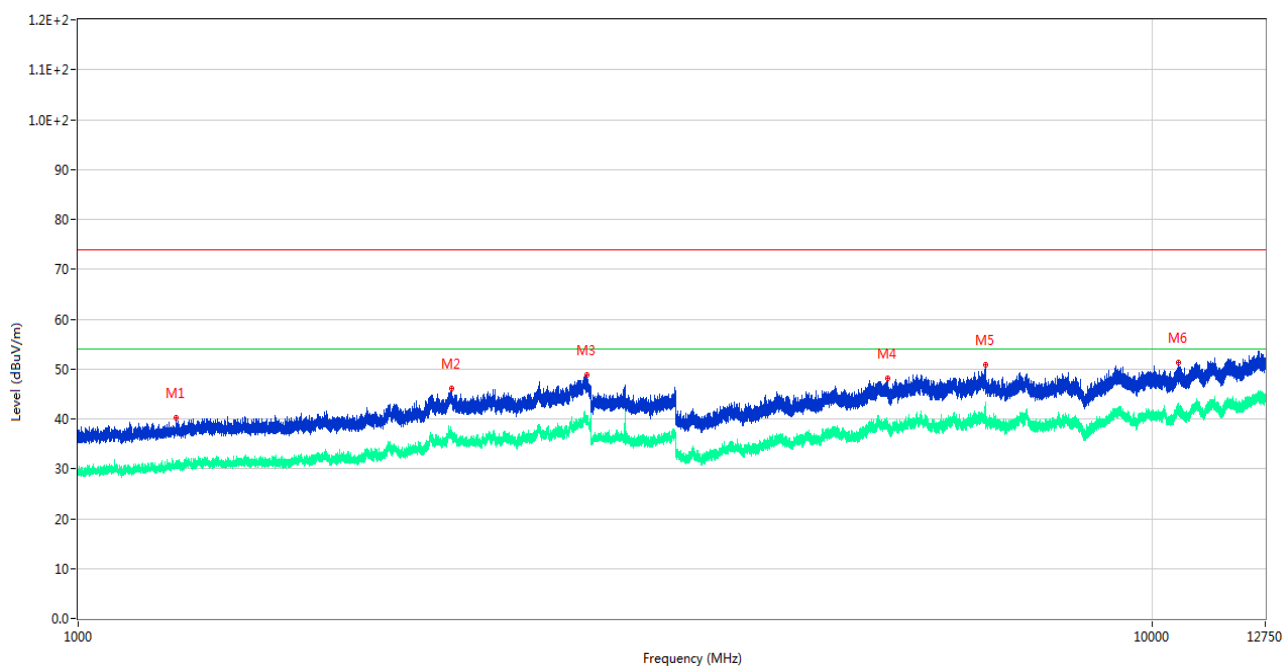
Test Mode 1

5) Test Antenna Vertical, 1 GHz – 12.75 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	1231.400	39.48	-15.38	74.0	34.52	Peak	332.80	100	Vertical	Pass
1**	1231.400	30.83	-15.38	54.0	23.17	AV	332.80	100	Vertical	Pass
2	1520.600	41.98	-14.97	74.0	32.02	Peak	64.10	100	Vertical	Pass
2**	1520.600	30.63	-14.97	54.0	23.37	AV	64.10	100	Vertical	Pass
3	2226.400	45.68	-9.23	74.0	28.32	Peak	30.10	100	Vertical	Pass
3**	2226.400	37.24	-9.23	54.0	16.76	AV	30.10	100	Vertical	Pass
4	3229.200	47.36	-8.15	74.0	26.64	Peak	171.10	100	Vertical	Pass
4**	3229.200	40.95	-8.15	54.0	13.05	AV	171.10	100	Vertical	Pass
5	5620.800	48.41	-2.54	74.0	25.59	Peak	75.70	100	Vertical	Pass
5**	5620.800	39.64	-2.54	54.0	14.36	AV	75.70	100	Vertical	Pass
6	9390.850	51.38	19.98	74.0	22.62	Peak	219.20	100	Vertical	Pass
6**	9390.850	41.38	19.98	54.0	12.62	AV	219.20	100	Vertical	Pass

6) Test Antenna Horizontal, 1 GHz – 12.75 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	1233.800	40.22	-15.33	74.0	33.78	Peak	201.70	100	Horizontal	Pass
1**	1233.800	31.61	-15.33	54.0	22.39	AV	201.70	100	Horizontal	Pass
2	2228.900	46.10	-9.65	74.0	27.90	Peak	327.60	200	Horizontal	Pass
2**	2228.900	36.82	-9.65	54.0	17.18	AV	327.60	200	Horizontal	Pass
3	2974.300	48.83	-5.46	74.0	25.17	Peak	269.10	100	Horizontal	Pass
3**	2974.300	39.68	-5.46	54.0	14.32	AV	269.10	100	Horizontal	Pass
4	5669.000	48.11	-1.68	74.0	25.89	Peak	181.10	100	Horizontal	Pass
4**	5669.000	38.77	-1.68	54.0	15.23	AV	181.10	100	Horizontal	Pass
5	6997.600	50.81	0.44	74.0	23.19	Peak	0.00	100	Horizontal	Pass
5**	6997.600	42.03	0.44	54.0	11.97	AV	0.00	100	Horizontal	Pass
6	10590.875	51.31	20.30	74.0	22.69	Peak	166.10	100	Horizontal	Pass
6**	10590.875	41.47	20.30	54.0	12.53	AV	166.10	100	Horizontal	Pass

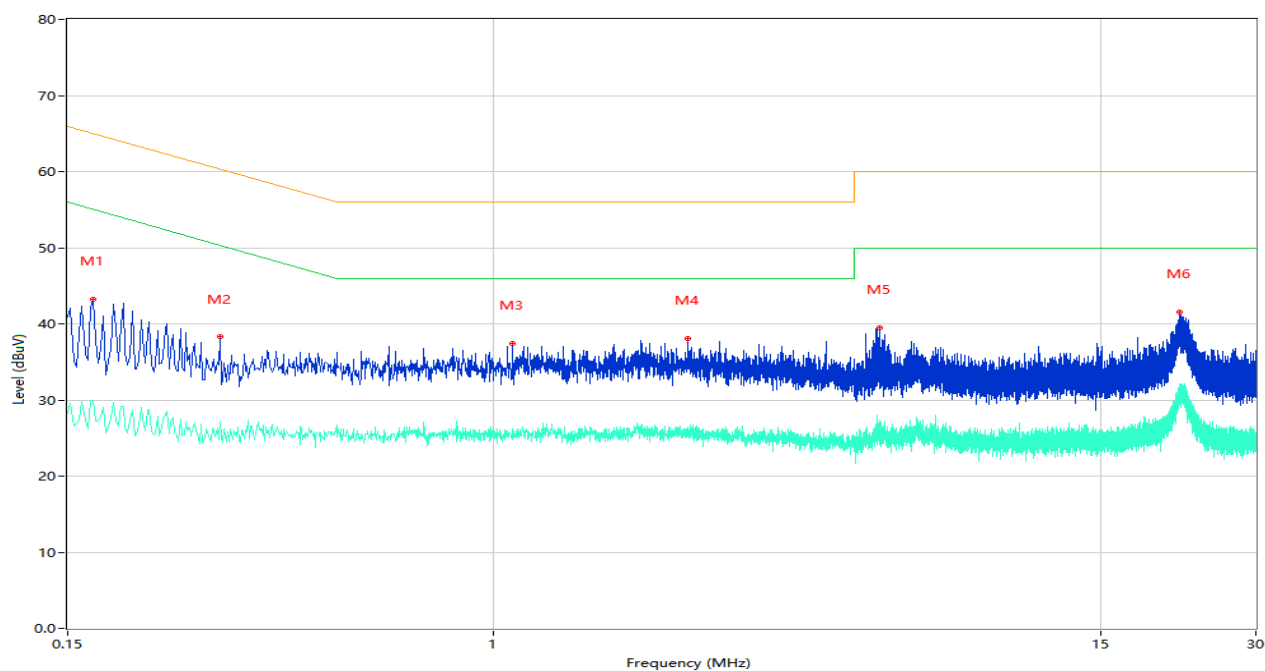
Equipment Information						
Equipment Name	Supplier	Model	Serial No.	Cal. Date	Cal. Due	Use
Frequency Above 1 GHz						
EMI Receiver	Keysight	N9038A	MY53220118	2025.06.16	2026.06.15	☒
Amplifier (1-12GHz)	COM-MV	DLNAB-1000- 12000-002	18080279	2024.11.28	2025.11.27	☒
Amplifier (0.8-21GHz)	Mini-Circuits	ZVA-213-S+	619201336	2024.11.28	2025.11.27	☒
Test Antenna- Horn	SCHWARZB ECK	BBHA 9120D	1148	2025.05.28	2028.05.27	☒
Anechoic Chamber (#4)	ChangNing	9m*6m*6m	101	2023.03.04	2026.03.03	☒
Description	Supplier	Name	Version	/		Use
Test Software	BALUN	BL410-E	V22.930	/		☒

A.2 Conducted Emission, AC Ports

Sample No.	S05	Temperature	22.7℃
Humidity	54%RH	Pressure	101kPa
Test Engineer	Huang Penghui	Test Date	2025.10.22

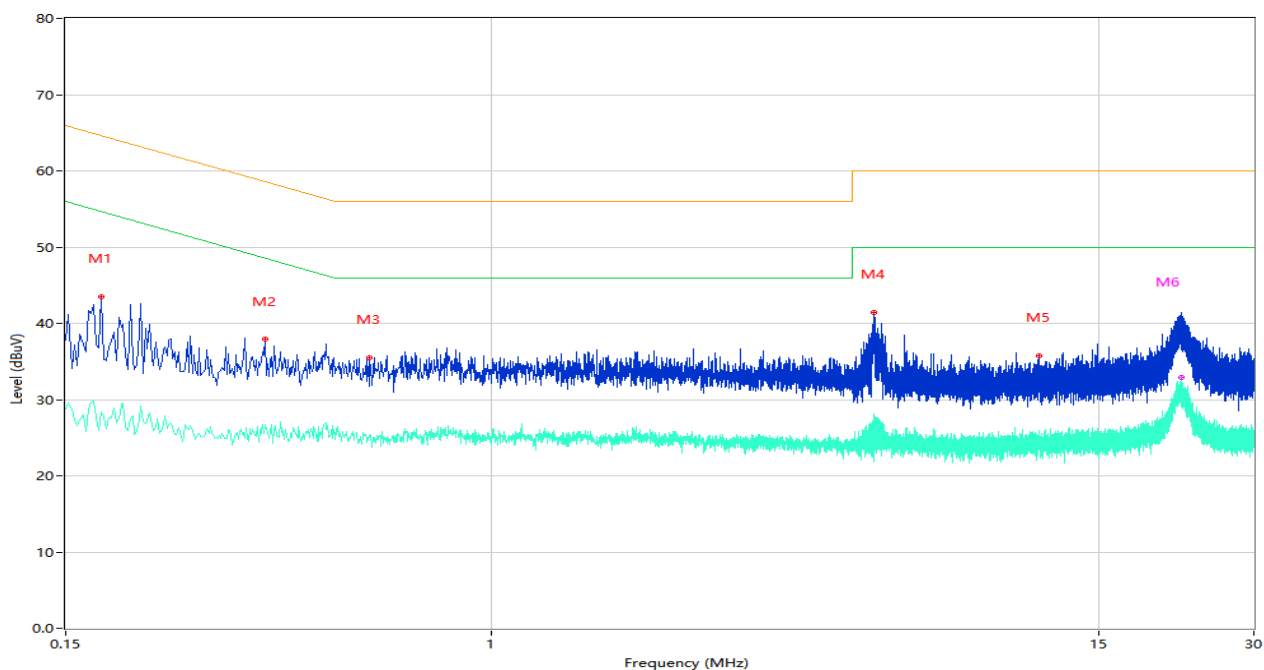
Test Mode 1

1) AC Ports - L Phase



No.	Frequency (MHz)	Results (dBuV)	Factor (dB)	Limit (dBuV)	Margin (dB)	Detector	Line	Verdict
1	0.168	43.26	9.85	65.06	21.80	Peak	L	Pass
1**	0.168	29.89	9.85	55.06	25.17	AV	L	Pass
2	0.296	38.28	9.82	60.35	22.07	Peak	L	Pass
2**	0.296	27.05	9.82	50.35	23.30	AV	L	Pass
3	1.090	37.43	10.09	56.00	18.57	Peak	L	Pass
3**	1.090	26.24	10.09	46.00	19.76	AV	L	Pass
4	2.380	38.04	10.25	56.00	17.96	Peak	L	Pass
4**	2.380	25.19	10.25	46.00	20.81	AV	L	Pass
5	5.594	39.52	10.46	60.00	20.48	Peak	L	Pass
5**	5.594	24.99	10.46	50.00	25.01	AV	L	Pass
6	21.396	41.55	10.96	60.00	18.45	Peak	L	Pass
6**	21.396	30.46	10.96	50.00	19.54	AV	L	Pass

2) AC Ports - N Phase



No.	Frequency (MHz)	Results (dBuV)	Factor (dB)	Limit (dBuV)	Margin (dB)	Detector	Line	Verdict
1	0.176	43.49	9.85	64.67	21.18	Peak	N	Pass
1**	0.176	28.43	9.85	54.67	26.24	AV	N	Pass
2	0.366	37.87	10.75	58.59	20.72	Peak	N	Pass
2**	0.366	26.71	10.75	48.59	21.88	AV	N	Pass
3	0.582	35.53	10.17	56.00	20.47	Peak	N	Pass
3**	0.582	25.08	10.17	46.00	20.92	AV	N	Pass
4	5.522	41.42	10.50	60.00	18.58	Peak	N	Pass
4**	5.522	24.41	10.50	50.00	25.59	AV	N	Pass
5	11.512	35.73	10.72	60.00	24.27	Peak	N	Pass
5**	11.512	24.32	10.72	50.00	25.68	AV	N	Pass
6	21.708	40.12	11.16	60.00	19.88	Peak	N	Pass
6**	21.708	32.93	11.16	50.00	17.07	AV	N	Pass

Equipment Information						
Equipment Name	Supplier	Model	Serial No.	Cal. Date	Cal. Due	Use
EMI Receiver	KEYSIGHT	N9010B	MY57110309	2025.06.16	2026.06.15	☒
LISN	SCHWARZB ECK	NSLK 8127	8127-687	2025.04.29	2026.04.28	☒
Shielded Room	YiHeng Electronic Co., Ltd	3.5m*3.1m*2. 8m	112	2025.02.14	2028.02.13	☒
Description	Supplier	Name	Version	/		Use
Test Software	BALUN	BL410-E	V22.930	/		☒

ANNEX B TEST SETUP PHOTOS

Please refer the document “BL-SZ25A0561-AE.PDF”.

ANNEX C EUT EXTERNAL PHOTOS

Please refer the document “BL-SZ25A0561-AW.PDF”.

ANNEX D EUT INTERNAL PHOTOS

Please refer the document “BL-SZ25A0561-AI.PDF”.

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